

Notice of References Cited	Application/Control No. 10/783,743	Applicant(s)/Patent Under Reexamination AOKI ET AL.	
	Examiner Eueng-nan Yeh	Art Unit 2624	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0068089	04-2003	Sano et al.	382/232
*	B	US-7,236,637	06-2007	Sirohey et al.	382/240
	C	US-			
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	F	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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